


<b>Search Notes</b>  	<b>Application/Control No.</b>  10500140	<b>Applicant(s)/Patent Under Reexamination</b>  SEKO ET AL.
	<b>Examiner</b>  /Erma Cameron/	<b>Art Unit</b>  1792

SEARCHED			
Class	Subclass	Date	Examiner
427	493	3/9/2008	ecc
427	493, 355, 356, 358, 368	9/1/2008	ecc

SEARCH NOTES		
Search Notes	Date	Examiner
reviewed inventors in PALM	3/8/2008	ecc
searched caplus, wpix, uspatall, jpio on inventors (not attached)	3/9/2008	ecc
searched fprs, epo, jpo, derwent, ibmtdb	9/1/2008	ecc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
427	493, 355, 356, 358, 368	9/1/2008	ecc

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